Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/828,336	LEE, TAE-KYOUNG	
Examiner	Art Unit	_

2861

Hai C. Pham

SEARCHED			
Class	Subclass	Date	Examiner
347	241-245, 256-261, 263	12/14/2006	HP

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARC (INCLUDING SEA	H NOTES ARCH STRATEGY)
	DATE	EXMR
EAST Text Search	12/14/2006	HP